

<b>Notice of References Cited</b>	Application/Control No. 10/651,185		Applicant(s)/Patent Under Reexamination HAUEIS, MARTIN	
	Examiner Pablo N. Tran		Art Unit 2618	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0094848	07-2002	Amin et al.	455/572
*	B	US-5,774,805	06-1998	Zicker, Robert G.	455/426.1
*	C	US-2005/0090246	04-2005	Leermakers, Rene	455/428
*	D	US-2004/0235414	11-2004	Amin et al.	455/003.01
*	E	US-2005/0176458	08-2005	Shklarsky et al.	455/523
*	F	US-2005/0026561	02-2005	Shklarsky et al.	455/011.1
*	G	US-2004/0203835	10-2004	Trottier et al.	455/454
*	H	US-2004/0176085	09-2004	Phillips et al.	455/418
*	T	US-2004/0125779	07-2004	Kelton et al.	370/338
*	J	US-2004/0009774	01-2004	Kotzin et al.	455/450
*	K	US-2003/0220091	11-2003	Farrand et al.	455/404.1
*	L	US-2003/0092377	05-2003	Hill, George E.	455/3.06
*	M	US-2003/0070174	04-2003	Solomon, Merrill	725/98

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/651,185	Applicant(s)/Patent Under Reexamination HAUEIS, MARTIN	
	Examiner Pablo N. Tran	Art Unit 2618	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0239445	10-2005	Karaoguz et al.	455/414.1
*	B	US-6,647,015	11-2003	Malkemes et al.	370/401
*	C	US-6,526,581	02-2003	Edson, Richard	725/74
*	D	US-5,465,397	11-1995	Pickert, William F.	455/62
*	E	US-5,594,782	01-1997	Zicker et al.	455/417
*	F	US-5,623,531	04-1997	Nilssen, Ole K.	379/56.2
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.